

SIGC25T120CS2

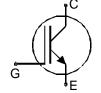
IGBT Chip in NPT-technology

FEATURES:

- 1200V NPT technology 175µm chip
- low turn-off losses
- short tail current
- positive temperature coefficient
- · easy paralleling

This chip is used for:

IGBT Modules



Applications:

• drives, SMPS, resonant applications

Chip Type	V _{CE}	I _{Cn}	Die Size	Package	Ordering Code
SIGC25T120CS2	1200V	15A	5.71 x 4.53 mm ²	sawn on foil	Q67050-A4197

MECHANICAL PARAMETER:

Raster size	5.71 x 4.53	mm ²			
Emitter pad size	2x (2.18 x 1.6)				
Gate pad size	1.09 x 0.68				
Area total / active	25.9 / 18.7				
Thickness	180	μm			
Wafer size	150	mm			
Flat position	270	grd			
Max.possible chips per wafer	555 pcs				
Passivation frontside	Photoimide				
Emitter metallization	3200 nm Al Si 1%				
Collector metallization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding				
Die bond	electrically conductive glue or solder				
Wire bond	AI, <500μm				
Reject Ink Dot Size	Ø 0.65mm ; max 1.2mm				
Recommended Storage Environment store in original container, in dry nitring container, in dry ni					



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MAXIMUM RATINGS:

Parameter	Symbol	Value	Unit
Collector-emitter voltage, T _j =25 °C	V _{CE}	1200	V
DC collector current, limited by T _{jmax}	I _C	1)	А
Pulsed collector current, t _p limited by T _{jmax}	I _{cpuls}	45	Α
Gate emitter voltage	V _{GE}	±20	V
Operating junction and storage temperature	T _j , T _{stg}	-55 + 150	°C

¹⁾ depending on thermal properties of assembly

STATIC CHARACTERISTICS (tested on chip), T_{j} =25 °C, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
Turumeter	- Cyllibol	Conditions	min.	typ.	max.	Oint
Collector-emitter breakdown voltage	V _{(BR)CES}	V_{GE} =0V , I_{C} =1.5mA	1200			
Collector-emitter saturation voltage	V _{CE(sat)}	V _{GE} =15V, I _C =15A	2.7	3.2	3.7	V
Gate-emitter threshold voltage	V _{GE(th)}	I_C =0.6mA , V_{GE} = V_{CE}	4.5	5.5	6.5	
Zero gate voltage collector current	I _{CES}	V _{CE} =1200V , V _{GE} =0V			2	μA
Gate-emitter leakage current	I _{GES}	V _{CE} =0V , V _{GE} =20V			120	nA

ELECTRICAL CHARACTERISTICS (tested at component):

Parameter	Symbol	Conditions	Value			Unit
r ai ailietei	Symbol		min.	typ.	max.	
Input capacitance	Ciss	V _{CE} =25V,	-	1000		pF
Output capacitance	Coss	$V_{GE}=0V$,	-	150		
Reverse transfer capacitance	C _{rss}	f=1MHz	-	70		

SWITCHING CHARACTERISTICS (tested at component), Inductive Load

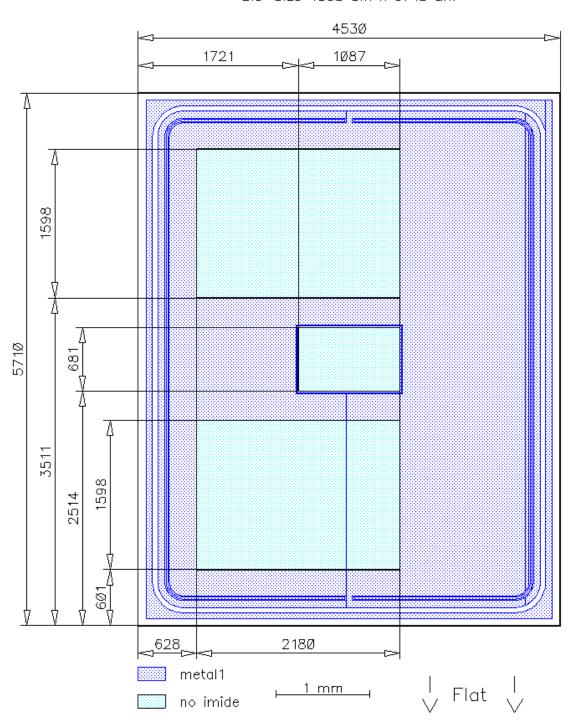
Parameter	Symbol	Conditions 1)	Value			Unit
- arameter	Symbol		min.	typ.	max.	Offic
Turn-on delay time	$t_{d(on)}$	<i>T</i> _j =125°C	-	60		ns
Rise time	t_{r}	$V_{\rm CC} = 600 \text{V}$,	-	50		
Turn-off delay time	$t_{d(off)}$	I _C =15A, V _{GE} =-15/15V,	-	400		
Fall time	t_{f}	R_{G} = 47 Ω	-	60		

¹⁾ values also influenced by parasitic L- and C- in measurement and package.



CHIP DRAWING:

Die-Size 4530 um x 5710 um





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FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the device data sheet	Eupec	FP15R12KS4C					
DESCRIPTION:							
AQL 0,65 for visual inspection according to failure catalog							
Electrostatic Discharge Sensitive Device according to MIL-STD 883							
Test-Normen Villach/Prüffeld							

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